

Notice of References Cited

Application/Control No.

10/601,383

Applicant(s)/Patent Under
Reexamination
PUSTERLA ET AL.

Examiner

Yelena G. Gakh, Ph.D.

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,653,144	11-2003	Nishina et al.	436/161
*	B	US-5,194,233	03-1993	Kitahara et al.	423/210
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1154268 A2	11-2001	European Patent	KETKAR et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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